

MICROSTRUCTURE AND ITS FABRICATION METHOD

BACKGROUND OF THE INVENTION

Field of the Invention

5 The present invention relates to a
microstructure and its fabrication method on the
field of micromachines. More particularly, the
present invention relates to a micro dynamic-value
sensor, microactuator and micro optical deflector
10 each having a member torsion-vibrating about a
torsion axis.

Related Background Art

 In recent years, various units have been
improved for high function and small size because of
15 development of microelectronics as represented by
high integration degree of semiconductor devices.
The same is said for an apparatus using a
micromachine device (such as a micro optical
deflector, micro dynamic-value sensor or
20 microactuator having a member torsion-vibrating about
a torsion axis). For example, an image display
apparatus such as a laser-beam printer or head-mount
display which performs optical scanning by using an
optical deflector, and a light-capturing apparatus of
25 an input device such as a bar code reader have been
also improved for high function and small size and
moreover, application of them to a portable product

is desired. Furthermore, not only the application of a micromachine device to the portable product but also improvement of performances of the device such as stability of torsional vibration such as external
5 vibration to noises, impact resistance and service life have been particularly requested to the device in addition to further downsizing of the device for practical use.

For example, Japanese Patent Application Laid-
10 Open No. 09-230275, 10th International Conference on Solid-State Sensors and Actuators (Transducers '99) pp. 1002-1005 is disclosed as a propose for the above request.

(First conventional example)

15 FIG. 16 is a perspective view showing a micro optical deflector of the first conventional example disclosed in U.S. Patent No. 5,982,521.

A torsion spring 1005 is set to a housing 1001 by a fixing jig 1002 while it is pulled at a tension.
20 Moreover, a magnet-provided mirror 1003 is fixed nearby the center of the torsion spring 1005 by an adhesive (not shown). The magnet-provided mirror 1003 is made of Ni-Co (nickel-cobalt) or Sm-Co (samarium-cobalt) having a thickness of 0.3 mm, a
25 length of 3 mm and a width of 6 mm. The torsion spring 1005 is made of a superelastic alloy (e.g. Ni-Ti alloy) and has a central portion of about 140 μ m

in line diameter and about 10 mm in length. Moreover, the portion where the torsion spring 1005 is fixed to the housing 1001 is thicker than the central portion to which the magnet-provided mirror 1003 is fixed, as
5 a result of electroless plating or the like. The fixed portion with the housing serves as a housing fixed portion 1013.

Moreover, a coil 1007 is wound on a core 1006 by about 300 turns. The coil 1007 is fixed to the
10 housing 1001 by a screw (not shown) through a tapped hole 1008 formed on the core 1006 and a hole 1004 formed on the housing 1001. Furthermore, a pulse-current generator 1009 is connected to the both ends of the wound wire of the coil 1007. By supplying a
15 current at, for example 3 V and about 100 mA to the coil, an alternate magnetic field is generated and the magnet-provided mirror 3 vibrates. A laser beam 1010 emitted from a light source 1011 is reflected from the magnet-provided mirror 1003 and the magnet-
20 provided mirror 1003 resonates and thereby, the laser beam is scanned on a plane 1012 to be scanned.

The housing fixed portion 1013 is tapered by coating processing such as electroless plating. Therefore, it is possible to moderate concentration
25 of stress on the housing fixed portion 1013 at the time of driving and moreover, the torsion spring 1005 is prevented from disconnection.

(Second conventional example)

FIG. 14 is a top view of the hard-disk-head gimbals of the second conventional example disclosed in 10th International Conference on Solid-State
5 Sensors and Actuators (Transducers '99) pp. 1002-1005. The gimbals is set to the front end of a hard-disk-head suspension to elastically allow a magnetic head to roll and pitch. The gimbals 2020 has a support frame 2031 rotatably supported by roll torsion bars
10 2022 and 2024 inside. Moreover, a head support 2030 rotatably supported by pitch torsion bars 2026 and 2028 is formed inside the support frame 2031. Torsional axes (refer to the orthogonal chain lines in FIG. 14) of the roll torsion bars 2022 and 2024
15 and pitch torsion bars 2026 and 2028 are orthogonal to each other and take charge of roll and pitch of the head support 2030 respectively.

FIG. 15 is a sectional view taken along the cutting-plane line 2006 in FIG. 14. As shown in FIG.
20 15, the sectional shape of the torsion bar 2022 is T-shaped and the gimbals 2020 is constituted so as to have a rib.

As shown in FIG. 15, the torsion bar having the T-shaped cross section has a large moment of inertia
25 of the cross section though it has a small polar moment of inertia of the cross section compared to the case of a torsion bar having a circular cross

section or rectangular cross section. Therefore, it is possible to provide a torsion bar which is not easily deflected though comparatively easily twisted. That is, it is possible to provide a torsion bar
5 having a high stiffness in the direction vertical to the torsion axis while securing a sufficient compliance in the torsional direction.

Moreover, there is an advantage that it is possible to further downsize a torsion bar because it
10 is possible to provide a short torsion bar for obtaining a necessary compliance.

Thus, by using the above torsion bar having a T-shaped cross section, it is possible to provide a microgimbals which has a sufficient compliance in
15 roll and pitch directions and a sufficient stiffness in other directions and which can be further downsized.

However, the first and second conventional examples have the problems described below.

20 In the case of the first conventional example, the torsion spring 1005 is a wire rod and its sectional shape is circular. A microstructure having a torsion spring of the above sectional shape has a problem that the structure cannot be accurately
25 driven because its torsion spring is easily deflected to receive the structure external vibrations or move the torsion axis of the torsion spring.

Moreover, because the torsion spring 1005 is easily deflected due to an external impact, there is a problem that the magnet-provided mirror 1003 is greatly displaced in the translational direction
5 (that is, direction vertical to torsion axis) and thereby, a trouble that the torsion spring 1005 is broken easily occurs.

Therefore, when applying the above micro optical deflector to a light scanning display, there
10 is a problem that an image is deformed due to external vibrations or a spot shape is changed. Moreover, there is a problem that a display is broken due to an impact. This leads to a larger problem when a light scanning display is formed into a
15 portable type.

Moreover, in the case of the first conventional example, the torsion spring 1005 is formed so that the wire diameter of the housing fixed portion 1013 fixed to the housing 1001 becomes large for the
20 support portion which supports the magnet-provided mirror 1003. Stress concentration caused by torsional vibration also occurs in the housing fixed portion 1013. However, because the torsional vibration is a relative movement of the magnet-
25 provided mirror 1003 to the housing 1001, stress concentration also occurs in the support portion which supports the magnet-provided mirror 1003 of the

torsion spring 1005. Therefore, the first conventional example has a problem that stress concentration on the support portion supporting the magnet-provided mirror 1003 in the torsion spring 1005 cannot be moderated and thereby, the effect of preventing disconnection of the torsion spring 1005 cannot be sufficiently expected.

Finally, the sectional shape of the portion of the torsion spring 1005 to be mainly displaced in the torsional direction is circular and the housing fixed portion 1013 is designed so as to obtain the effect of preventing disconnection by further increasing the wire diameter from the above portion to be mainly displaced. However, there is a problem that the housing 1001 for fixing the housing fixed portion 1013 must be also increased in size because of the structure of the housing fixed portion 1013. Particularly, to downsize a micro optical deflector, dimensions including the thickness of the housing 1001 and the wire diameter of the torsion spring 1005 become larger problems because they become similar on order.

The second conventional example has a problem that the T-shaped-cross-sectional torsion bar is easily broken because stress is concentrated on the support portions at the both ends of the torsion bar (for example, the support portion for the head

support 2030 and the support portion for the support
frame 2031 in the roll torsion bars 2028 and 2026, or
the support portion for the support frame 2031 and
the support portion for the gimbals 2020 in the roll
5 torsion bars 2022 and 2024). Therefore, unless the
torsion bar is set long enough, it is impossible to
drive the torsion bar at a large displacement angle.
Thereby, not only downsizing is impossible but also
the torsion bar is easily deflected even if greatly
10 lengthening the torsion bar and the head support 2030
is greatly translated in the direction vertical to
the torsion axis due to an external impact.

Therefore, when mounting the hard-disk-head gimbals
of the second conventional example on a hard disk, a
15 trouble occurs in the hard disk because the gimbals
contacts with a recording medium due to an external
vibration or impact or a head is broken. This
becomes a larger problem when the hard disk is formed
into a portable type.

20 Moreover, there is a problem that a large
stress is repeatedly loaded due to the above stress
concentration even if a breakage does not occur and
thereby, a torsion bar easily early causes a fatigue
failure due to a repetitive stress.

25 The present invention has been accomplished to
solve the above conventional problems and its object
is to provide a compact microstructure having less

unnecessary vibrations and a long service life even at a large torsional angle and its fabrication method and an optical apparatus using the microstructure.

5 SUMMARY OF THE INVENTION

Therefore, the present invention provides a microstructure having a support substrate and a movable plate, in which the movable plate is supported to the support substrate by an elastic support portion so that the plate can be freely
10 torsion-vibrated about a torsion axis, wherein

the elastic support portion has at least one concave portion,

at the both ends of a first section in which a
15 concave portion is formed, a second section in which the concave portion is not formed is arranged, and

the second section is connected with the movable plate and the support substrate.

Moreover, the present invention provides a
20 microstructure fabrication method comprising: a step of forming mask layers on the both faces of a silicon substrate; a step of removing the mask layer on a first face among the mask layers but leaving the mask layer on the contour portions of a support substrate,
25 an elastic support portion and a movable plate; a step of removing the mask layer opposite to the first mask face among the mask layers but leaving the mask

layer on the contour portions of the support substrate, the elastic support portion and the movable plate, and removing the mask layer on a portion for forming a concave portion of the elastic support portion; a step of dividing the silicon substrate into the support substrate, the elastic support portion and the movable plate and forming a concave portion on the elastic support portion by immersing the silicon substrate in an alkaline aqueous solution to subject the substrate to anisotropic etching; and a step of removing the mask layers on the silicon substrate.

Moreover, the present invention provides a microstructure fabrication method comprising: a step of forming mask layers on the both faces of a silicon substrate; a step of removing the mask layers on the both faces of the mask layer but leaving the mask layers on the contour portions of a support substrate, an elastic support portion and a movable plate, and moreover removing the mask layer on a portion for forming a concave portion of the elastic support portion; a step of dividing the silicon substrate into the support substrate, the elastic support portion and the movable plate and forming a concave portion on the elastic support portion by immersing the silicon substrate in an alkaline aqueous solution to subject the substrate to anisotropic etching and a

step of removing the mask layers on the silicon substrate.

BRIEF DESCRIPTION OF THE DRAWINGS

5 FIG. 1 is a perspective view showing a micro optical deflector of a first embodiment of the present invention;

 FIG. 2 is a sectional view taken along the line A-A in FIG. 1;

10 FIG. 3 is a perspective view for explaining a support substrate, movable plate, elastic support portion, concave portion and permanent magnet in FIG. 1;

 FIG. 4A is a top view for explaining the
15 elastic support portion and concave portion in FIG. 1 and FIG. 4B is a sectional view taken along the line S-S in FIG. 4A;

 FIGS. 5A, 5B, 5C and 5D are sectional views taken along the lines O-O, P-P, Q-Q and R-R in FIG.
20 4A;

 FIGS. 6A, 6B, 6C, 6D and 6E are illustrations for explaining a fabrication method of the optical deflector in FIG. 1;

 FIGS. 7A, 7B, 7C, 7D, 7E and 7F are
25 illustrations for explaining a step of forming an elastic support portion and a concave portion in the optical-deflector fabrication method in FIGS. 6A to

6E;

FIG. 8 is a perspective view showing an acceleration sensor of a second embodiment of the present invention;

5 FIG. 9A is a top view for explaining an elastic support portion and a concave portion in FIG. 8 and FIG. 9B is a sectional view taken along the line S-S in FIG. 9A;

FIGS. 10A, 10B, 10C and 10D are sectional views
10 taken along the lines O-O, P-P, Q-Q and R-R in FIG. 9A;

FIGS. 11A, 11B, 11C, 11D and 11E are illustrations for explaining a fabrication method of the acceleration-sensor in FIG. 8;

15 FIG. 12 is an illustration showing an embodiment of an optical apparatus using a micro optical deflector of the present invention;

FIG. 13 is an illustration showing another embodiment of the optical apparatus using the micro
20 optical deflector of the present invention;

FIG. 14 is an illustration showing the hard-disk-head gimbals of the second conventional example;

FIG. 15 is a sectional view of the hard-disk-head gimbals of the second conventional example in
25 FIG. 14; and

FIG. 16 is an illustration showing the optical deflector of the first conventional example.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

Embodiments of the present invention are described below in detail by referring to the accompanying drawings.

5 (First embodiment)

{General description, Mirror (Movable plate portion)}

FIG. 1 is a perspective view showing a configuration of the micro optical deflector of the first embodiment of the present invention. In FIG. 1,
10 a micro optical deflector 1 has a structure in which both ends of a movable plate 6 are supported to a support substrate 2 by an elastic support portion 3. The elastic support portion 3 elastically supports the movable plate 6 in the direction E about the axis
15 C (that is, torsion axis) so that the movable plate 6 can be freely torsion-vibrated. Moreover, as shown in FIG. 1, a concave portion 5 is formed on the elastic support portion 3. Furthermore, one face of the movable plate 6 serves as a reflection plane 4
20 which deflects the light incoming to the reflection plane 4 by a predetermined displacement angle due to the E-directional torsion of the movable plate 6.

Moreover, because the micro optical deflector 1 serving as a microstructure can torsion-vibrate the
25 movable plate 6 by using driving means, it is possible to provide an actuator by the microstructure and driving means. The driving means relatively

drives a support substrate and movable plate. In the case of this embodiment, the driving means uses a magnet or coil to be described later. When using a magnet or coil, it is possible to provide an
5 electromagnetic actuator.

(Magnet)

Moreover, a permanent magnet 7 such as a rare-earth-based permanent magnet containing samarium, iron and nitrogen is set to a face (hereafter,
10 referred to as "back") opposite to the face on which the reflection plane 4 is formed. Furthermore, the permanent magnet 7 is magnetized so that S and N poles are opposite to each other with interposition of the torsion axis C.

15 (Integral formation, Mirror substrate)

The support substrate 2, movable plate 6, reflection plane 4, elastic support portion 3 and concave portion 5 are integrally formed by single-crystal silicon in accordance with the micromachining
20 technique to which the semiconductor manufacturing technology is applied.

(Description of coil substrate)

Moreover, a coil substrate 8 is set in parallel with the support substrate 2 so that a coil 9 serving
25 as magnetism generation means is set nearby the permanent magnet 7 by keeping a desired distance from the magnet 7. The coil 9 is integrally formed in a

spiral shape by electroplating, for example, copper on the surface of the coil substrate 8 as shown in FIG. 1.

(Operations)

5 Operations of the micro optical deflector 1 of this embodiment are described below by referring to FIG. 2. FIG. 2 is a sectional view taken along the line A-A of the micro optical deflector 1 in FIG. 1. As shown in FIG. 2, the permanent magnet 7 is
10 magnetized so that S and N poles are opposite to each other with interposition of the torsion axis C. The direction is shown in FIG. 2. By supplying a current to the coil 9, a magnetic flux Φ is generated in relation to the direction of the current to be
15 supplied such as the direction in FIG. 2. An attraction and repulsion are generated on magnetic poles of the permanent magnet 7 in directions relating to the magnetic flux, and a torque T acts on the movable plate 6 elastically supported about the
20 torsion axis C. Similarly, by reversing the direction of the current to be supplied to the coil 9, a torque T acts in the opposite direction. Therefore, as shown in FIG. 2, it is possible to drive the movable plate 6 by an optional angle in accordance
25 with the current to be supplied to the coil 9. In FIG. 2, numeral 2 denotes a support substrate, 4 a reflection plane, and 8 a coil substrate.

(Resonation)

Moreover, by supplying an alternating current to the coil 9, it is possible to continuously torsion-vibrate the movable plate 6. In this case, 5 by almost equalizing the frequency of the alternating current with the resonant frequency of the movable plate 6 and resonating the movable plate 6, a larger displacement angle can be obtained.

(Scale)

10 The micro optical deflector 1 of this embodiment is driven at 19 kHz which is the resonant frequency of the movable plate 6 and a mechanical displacement angle of $\pm 10^\circ$. The support substrate 2, movable plate 6 and elastic support portion 3 are 15 constituted to have an equal thickness of 150 μm , and the B-directional (direction A-A in FIG. 1) width of the movable plate 6 is set to 1.3 mm and the torsion-axis-directional length of the plate 6 is set to 1.1 mm. That is, the surface of the movable plate has an 20 area of about several mm^2 (particularly, an area equal to or less than 2 mm^2) and the movable-plate-provided support substrate is a microstructure.

(Detailed description of configuration of elastic support portion)

25 The elastic support portion 3 and concave portion 5 are described below which are features of the present invention.

FIG. 3 is a perspective view of the support substrate 2 when viewing it from the back of it.

As shown in FIG. 3, in the case of this embodiment, the concave portion 5 is formed on the elastic support portion 3. As shown in FIGS. 1 and 3, the concave portion 5 is formed on the surface where the reflection plane 4 is formed and the back of the elastic support portion 3 respectively. Moreover, two elastic support portions 3 which support the movable plate 6 have the same shape.

Therefore, the elastic support portion 3 and concave portion 5 enclosed by a broken line in FIG. 3 are described below by referring to FIGS. 4A and 4B and FIGS. 5A to 5D. FIG. 4A is a top view obtained by particularly enlarging the elastic support portion 3 enclosed by a broken line in FIG. 3 and FIG. 4B is a sectional view taken along the line S-S in FIG. 4A. Moreover, FIGS. 5A to 5D show sectional views of the elastic support portion 3 taken along the lines O-O, P-P, Q-Q and R-R shown in FIGS. 4A and 4B.

As shown in FIG. 4A, the concave portion 5 is not formed at the both ends of the elastic support portion 3 in the torsion-axis direction, that is, one end of the portion 3 connected with the movable plate 6 and the other end of the portion 3 connected with the support substrate 2. Therefore, the elastic support portion 3 is constituted so that a section N

in which the concave portion 5 is formed is put between sections M in which the concave portion 5 is not formed. Numeral 10 denotes a corner.

FIG. 4B shows a sectional view taken along the line S-S in FIG. 4A. In the case of the micro optical deflector 1 of this embodiment, the concave portion 5 is constituted by the four (111) equivalent planes of silicon crystal planes. Among the four silicon crystal planes, two inclined planes 11 shown in FIGS. 4A and 4B are tilted by approx. 54.7° from the (100) equivalent plane which is a plane forming on the reflection plane and its back respectively, as illustrated. The section in which the inclined planes 11 are formed is referred to as a section N' and other section N is referred to as a section N". Therefore, in the case of the optical deflector 1 of this embodiment, the elastic support portion 3 is formed so that the section N in which the concave portion 5 is formed is put between the sections M in which the concave portion 5 is not formed and in the section N, and the section N" is interposed by the sections N' in which the inclined plane 11 is formed. In this case, the (111) equivalent plane and (100) equivalent plane are general names of crystal planes shown by the planes (111), (1-1-1), (-1-11) and (-100).

(Description that sectional shape changes)

FIG. 5A shows a sectional shape of the elastic support portion 3 in the section M (line O-O in FIGS. 4A and 4B). Reference symbol C denotes a torsion-axis.

5 FIG. 5D shows a sectional shape in the section N" (line R-R in FIG. 4). In the section N", the sectional shape of the elastic support portion 3 becomes an X-shaped polygon because the concave portion 5 is formed. That is, the cross section of
10 the section N" has a small polar moment of inertia of the cross section compared to the cross section of the section M in FIG. 5A.

When the concave portion 5 is not formed on the elastic support portion 3, large stress concentration
15 occurs at corners 10 shown in FIG. 4A and this becomes a main factor of breakage of the elastic support portion 3. However, by forming the concave portion 5, the elastic support portion 3 of this embodiment has a small polar moment of inertia of the
20 cross section from the section M to the section N". Therefore, the torsion angle θ in the section M becomes smaller per unit length than that in the section N and thereby, corners 10 are not greatly strained. Therefore, it is possible to moderate
25 stress concentration on the corners 10.

Moreover, the sectional shape of the section N" still has a large moment of the inertia of cross

section in the direction causing a deflection
vertical to the torsion axis even when the concave
portion 5 is formed, and it is possible to realize an
elastic support portion which does not easily cause
5 unnecessary vibrations other than torsional vibration
or unnecessary displacement.

FIGS. 5B and 5C show sectional shapes in the
section N' (taken along the lines P-P and Q-Q in FIGS.
4A and 4B, respectively). As shown in FIG. 4B, the
10 concave portion 5 formed on the inclined planes 11 is
made deeper toward the section N'' from the section M
by the inclined planes 11 formed in the section N'.
Therefore, as shown in FIGS. 5B and 5C, the sectional
shape becomes an intermediate polygon slowly changing
15 from the section M to the section N''.

Therefore, because the polar moment of inertia
of the cross section also continuously changes, it is
possible to further moderate new stress concentration
caused at a sudden change point, compared to the case
20 in which change of shapes from the section M to the
section N'' suddenly occurs, and realize a more
preferable conformation.

Thus, as typically shown as the section M and
section N for this embodiment, by forming a concave
25 portion on an elastic support portion, it is possible
to moderate the stress concentration caused nearby
the both ends of the elastic support portion, prevent

the elastic support portion from breaking, and improve a micro optical deflector for wide deflection angle and long service life. Moreover, by forming a sectional shape having a small polar moment of inertia of the cross section and a comparatively large moment of inertia of the cross section like the section N, it is possible to realize a micro optical deflector which can be easily twisted and which does not cause unnecessary vibration or displacement against external vibration or impact in the direction vertical to a torsion axis.

The above effect is not restricted to only the sectional shape of an elastic support portion and concave portion of this embodiment. It is possible to achieve the objects of the present invention by using an optional elastic support portion and concave portion.

Moreover, as particularly shown as the section N' in which the inclined plane 11 is typically formed, it is possible to further moderate stress concentration and constitute a micro optical deflector of the present invention into a more preferable mode by tilting the side wall of a concave portion from a face vertical to a torsion axis so that an intermediate sectional shape is formed between a section in which the concave portion is not formed and a section in which the concave portion is

formed.

Moreover, by integrally forming the support substrate 2, movable plate 6, elastic support portion 3 and concave portion 5 from single-crystal silicon like this embodiment, it is possible to realize a micro optical deflector having a large mechanical Q value. This shows that the vibration amplitude for input energy at the time of resonant driving increases. Therefore, a micro optical deflector of the present invention can be formed into a compact and power-saving deflector at a large deflection angle.

Furthermore, in the case of this embodiment, by forming the sectional shape of the section N'' into an X-shaped polygon, it is possible to realize a sectional shape having a smaller polar moment of inertia of the cross section and a larger moment of inertia of the cross section. Furthermore, because it is possible to realize a mode in which the torsion axis C almost passes through the center of gravity of the movable plate 6, it is possible to decrease the displacement from the axis C of torsional vibration. Therefore, it is possible to form a micro optical deflector of the present invention into a more preferable mode.

Moreover, in the case of this embodiment, a sectional shape vertical to the torsion axis C of the

movable plate 6 constituted by the (100) and (111) equivalent planes formed simultaneously with an elastic support portion is a polygon of which the side wall is caved as shown in FIG. 2. Therefore, compared to the case in which the cross section of a movable plate is rectangular, the moment of inertia is reduced and at the same time, the stiffness is kept high. Therefore, even when driving a micro optical deflector at a high speed, a reflection plane is only slightly deformed and even when setting a resonant frequency high, it is possible to set a spring constant of the torsion of an elastic support portion at a low value. Therefore, a large deflection angle is obtained at a small torque.

15 (Fabrication process)

Then, fabrication methods of the support substrate 2, elastic support portion 3, movable plate 6 and concave portion 5 of this embodiment are described below by referring to FIGS. 6A to 6E and FIGS. 7A to 7F. FIGS. 6A to 6E and FIGS. 7A to 7F are process charts showing fabrication methods of the support substrate 2, elastic support portion 3, movable plate 6 and concave portion 5 in accordance with anisotropic etching using an alkaline aqueous solution. Particularly, FIGS. 6A to 6E show schematic views of fabrication steps in cross sections taken along the line A-A in FIG. 1 and FIGS.

7A to 7F show schematic views of fabrication steps in cross sections taken along the line R-R in FIG. 4A. First, as shown in FIG. 6A, mask layers 101 made of silicon nitride are formed on the both faces of a
5 flat plate-shaped silicon substrate 104 in accordance with the low pressure chemical vapor deposition method or the like.

Then, as shown in FIG. 6B, the mask layer 101 on the face on which a reflection plane 4 is formed
10 is patterned in accordance with the contour of the support substrate 2, movable plate 6, elastic support portion 3 and concave portion 5 to be formed. The above patterning is performed by normal photolithography and dry etching using a gas which
15 corrodes silicon nitride (for example, CF_4). Moreover, as shown in FIG. 6C, the mask layer 101 is patterned on a face on which the reflection plane 4 is not formed in accordance with the contour of the support substrate 2, movable plate 6, elastic support portion
20 3 and concave portion 5 to be formed. Also in this case, the patterning is performed in accordance with the same method as that in FIG. 6B.

Then, as shown in FIG. 6D, anisotropic etching is performed by immersing the silicon substrate in an
25 alkaline aqueous solution (such as potassium-hydroxide aqueous solution and tetramethylammonium-hydroxide aqueous solution) having corrosion rates

extremely different from each other depending on the crystal plane of single-crystal silicon for a desired period to form the support substrate 2 and movable plate 6 shown in FIG. 6D. In this case, the elastic support portion 3 and concave portion 5 are also formed at the same time. The anisotropic etching has a large etching rate on the (100) equivalent plane and a small etching rate on the (111) equivalent plane. Therefore, by progressing etching from the surface and back of the silicon substrate 104, it is possible to accurately form a shape enclosed by the (100) plane of the portion covered with the mask layer 101 and the (111) plane in accordance with the relation between the pattern of the mask layer 101 and the crystal plane of silicon. Details of the formation processes of the elastic support portion 3 and concave portion 5 in the above anisotropic etching step will be described later in detail by referring to FIGS. 7A to 7F.

Then, as shown in FIG. 6E, the mask layer 101 made of silicon nitride is removed and moreover, a metal having a high reflectance (such as aluminum) is vacuum-deposited as the reflection plane 4. According to the above fabrication method, the support substrate 2, movable plate 6 on which the concave portion 5 is formed, reflection plane 4, elastic support portion 3 and concave portion 5 are

integrally formed.

Thereafter, a paste-like magnetic material obtained by mixing rare-earth-based fine particles containing samarium, iron and nitrogen with a
5 junction material is formed on the back of the movable plate 6. In this case, for example, it is possible to form the magnetic material only on the back of the movable plate 6 through silk screen printing. Finally, the movable plate 6 is heated in
10 a magnetic field and then magnetized (for magnetizing direction, refer to FIG. 2) to form the permanent magnet 7. Thus, the micro optical deflector 1 as shown in FIG. 1 is completed.

{Fabrication process (formation process of torsion
15 bar serving as elastic support portion and concave portion)}

In this case, the formation process of the elastic support portion 3 and concave portion 5 in the anisotropic etching step shown in FIG. 6D is
20 described below in detail by referring to FIGS. 7A to 7F.

As shown in FIG. 7A, an opening 191 having a width of W_a along contours of the elastic support portion 3 and movable plate 6 is formed on the mask
25 layer 101, formed in the preceding step, corresponding to the contour of the portion in which the elastic support portion 3 and concave portion 5

and moreover, an opening 190 having a width of W_g is formed along the contour of the concave portion 5.

In this case, for example, as shown in FIG. 7B, both faces of the silicon substrate 104 are etched by using a potassium-hydroxide aqueous solution. As described above, the etching progresses so that an opening becomes smaller as the etching becomes deeper in accordance with the etching-rate difference between the (100) and (111) equivalent planes.

Then, as shown in FIG. 7C, in the case of the opening 190, all planes become the (111) equivalent plane and etching stops before the opening 190 having the width of W_g reaches the center of the silicon substrate 104. Therefore, the V-shaped concave portion 5 is formed. Moreover, in the case of the opening 191 having the width of W_a , etching progresses until the etching penetrates the substrate. As shown in FIG. 4B, because the (111) equivalent plane tilts by 54.7° from the (100) equivalent plane, the relation between the width w of the opening and the depth of the V-shaped concave portion 5 is shown as $d = w/2\tan 54.7^\circ$. That is, relations of $W_g < t/\tan 54.7^\circ$ and $W_a > t/\tan 54.7^\circ$ are satisfied. In this case, t denotes the thickness of the silicon substrate 104.

Then, as shown in FIGS. 7D and 7E, after a hole penetrates from the top and bottom of the opening 191,

etching progresses sideward.

Finally, as shown in FIG. 7F, the sidewall reaches the (111) equivalent plane and etching stops. Therefore, a caved shape of the (111) equivalent
5 plane is formed on side faces of the elastic support portion 3 and movable plate 6 (refer to FIG. 6D). Moreover, the sectional shape of the elastic support portion 3 taken along the line R-R in FIGS. 4A and 4B is formed into an X-shaped polygon.

10 Thus, according to the fabrication method of the micro optical deflector 1 of this embodiment, it is possible to form structures of the movable plate 6, elastic support portion 3 and concave portion 5 through one-time alkaline anisotropic etching.
15 Therefore, it is possible to fabricate micro optical deflectors in large quantities very inexpensively. Moreover, it is possible to correspond to design modification by adjusting a mask pattern and the etching time by photolithography. Therefore, it is
20 possible to fabricate a micro optical deflector more inexpensively in a shorter development period. Moreover, because shapes of the movable plate 6, elastic support portion 3 and concave portion 5 are decided in accordance with the (111) equivalent plane
25 of single-crystal silicon, it is possible to form the shapes at a high accuracy.

(Diffraction grating)

Though the reflection plane 4 is used in FIG. 1, it is possible to constitute a micro optical deflector which performs the same operation in accordance with torsional vibration of the movable plate 6 even if the reflection plane 4 uses a reflective diffraction grating. In this case, because deflected light serves as diffracted light for incident light, it is possible to obtain a plurality of deflected rays from one beam.

10 (Second embodiment)

(General description: Mechanical sensor)

FIG. 8 is a perspective view showing a configuration of an acceleration sensor serving as the mechanical sensor of the second embodiment of the present invention. In FIG. 8, the acceleration sensor 21 has a structure in which both ends of a movable plate 6 are supported to a support substrate 2 by an elastic support portion 3. The elastic support portion 3 elastically supports the movable plate 6 about the axis C (that is, torsion axis) so that it can be freely torsion-vibrated in the direction E. Moreover, a concave portion 5 is formed on the elastic support portion 3 as shown in FIG. 8. In FIG. 8, the same member as that in FIG. 1 is denoted by the same numeral

(Description of detection electrode and insulating substrate)

Moreover, an insulating substrate 210 is set in parallel with the support substrate 2 so that a detection electrode 216 is set opposite to the movable plate 6 nearby the movable plate 6 by keeping
5 a desired distance from the plate 6. The insulating substrate 210 is electrically grounded. For example, the detection electrode 216 is formed by vacuum-depositing aluminum on the insulating substrate 210, photolithgraphing and etching the detection electrode
10 216 along the contour of the electrode 216 and patterning the electrode 216. It is possible to adhere the support substrate 2 which is a silicon substrate and the insulating substrate 210 together through a spacer (not shown) so as to arrange the
15 substrates 2 and 210 in parallel by keeping a desired distance between them.

(Acceleration sensor, electrostatic actuator and principle)

When acceleration acts in the direction
20 vertical to the support substrate 2, an inertial force acts on the movable plate 6 and the movable plate 6 is displaced in the direction E about the torsion axis C of the elastic support portion 6. When the movable plate 6 is displaced in the
25 direction E, the electrostatic capacity between the movable plate 6 and detection electrode 216 changes because the distance between the movable plate 6 and

the detection electrode 216 changes. Therefore, by detecting the electrostatic capacity between the detection electrode 216 and movable plate 6, it is possible to detect acceleration.

5 However, when applying a voltage between the movable plate 6 and detection electrode 216, electrostatic attraction acts between the movable plate 6 and detection electrode 216 and the movable plate 6 is displaced in the direction E about the
10 torsion axis C of the elastic support portion 3. That is, the acceleration sensor of this embodiment can be used as an electrostatic actuator.

(Detailed description of elastic support portion 3 and concave portion 5)

15 The elastic support portion 3 and concave portion 5 enclosed by a broken line in FIG. 8 are described below by referring to FIGS. 9A and 9B and FIGS. 5A to 5D.

 The elastic support portion 3 and concave
20 portion 5 of this embodiment have the same effect as that of the elastic support portion 3 and concave portion 5 of the first embodiment. The difference between the first embodiment and the second
 embodiment lies in sectional shapes of the elastic
25 support portion 3 and concave portion 5 and the difference is described below.

 FIG. 9A is a top view obtained by particularly

enlarging the elastic support portion 3 and concave portion 5 enclosed by the broken line in FIG. 8 and FIG. 9B is a sectional view taken along the line S-S in FIG. 9A. Moreover, FIGS. 10A to 10D show

5 sectional views of the elastic support portion 3 taken along the lines O-O, P-P, Q-Q and R-R shown in FIGS. 9A and 9B.

As shown in FIG. 9A, the concave portion 5 is not formed nearby both ends of the elastic support
10 portion 3 but a section N in which the concave portion 5 is formed is interposed between sections M in which the concave portion 5 is not formed.

FIG. 9B shows a cross section taken along the line S-S in FIG. 9A. The concave portion 5 is formed
15 by four (111) equivalent planes of silicon crystal planes. Among the (111) equivalent planes, two inclined planes 11 shown in FIG. 9A and 9B tilt from the (100) equivalent plane by angle of approx. 54.7° as illustrated. The section in which the inclined
20 plane 11 is formed is referred to as a section N' and other section in the section N is referred to as N". Therefore, in the case of this embodiment, the elastic support portion 3 is constituted so that the section N in which the concave portion 5 is formed is
25 interposed between the sections M in which the concave portion 5 is not formed and moreover, the section N" is interposed between sections N' in which

the inclined plane 11 is respectively formed in the section N.

FIG. 10A shows the sectional shape of the elastic support portion 3 in the section M (taken
5 along the line O-O in FIG. 9A) which is almost trapezoidal.

FIG. 10D shows the sectional shape of the section N'' (taken along the line R-R in FIG. 9A), in which the sectional shape of the elastic support
10 portion 3 becomes a V-shaped polygon by forming the concave portion 5 therein.

Moreover, FIGS. 10B and 10C show sectional shapes of the section N' (taken along the lines P-P and Q-Q in FIG. 4A). Because the concave portion 5
15 at this portion becomes deeper from the section-M side toward the section-N'' side, it becomes an intermediate polygon in which the sectional shape slowly changes from the section M to the section N''.

That is, because the sectional shape changes
20 from the section M to the section N' and section N'', the same effect as the case of the change of the sectional shape from the section M to the section N' and section N'' in the first embodiment is obtained. Therefore, stress concentration on the corners 10 in
25 FIG. 9A is moderated and it is possible to realize an elastic support portion which does not easily cause unnecessary vibration or unnecessary displacement

other than torsional vibration.

(Special effect of V-shape cross section)

In the case of this embodiment, it is possible to realize a sectional shape having a smaller polar
5 moment of inertia of the cross section and a larger moment of inertia of the cross section by particularly forming the sectional shape of the section N" into a V-shaped polygon. Therefore, it is possible to form an acceleration sensor of the
10 present invention into a preferable mode.

{Fabrication process (Formation process of torsion bar serving as elastic support portion and concave portion)}

Then, fabrication methods of the support
15 substrate 2, elastic support portion 3, movable plate 6 and concave portion 5 of this embodiment are described below by referring to FIGS. 11A to 11E. FIGS. 11A to 11E particularly show sectional views taken along the line R-R in FIGS. 9A and 9B and
20 describe the formation process of the elastic support portion 3 and concave portion 5 in anisotropic etching steps in detail.

First, as shown in FIG. 11A, a mask layer 101 made of silicon nitride is formed on the both faces
25 of a flat plate-shaped silicon substrate 104 by the low-pressure chemical-vapor-phase synthetic method or the like to pattern the mask layer 101 in accordance

with the contour of the elastic support portion 3 and concave portion 5 to be formed. The above patterning is performed by normal photolithography and dry etching using a gas which corrodes silicon nitride (such as CF_4). In the case of the formed pattern, openings having widths of W_a , W_b and W_c are formed on the upper and lower faces of the silicon substrate 104 as shown in FIG. 11A. Openings 191 having widths of W_b and W_c are formed along contours of the elastic support portion 3 and movable plate 6 and moreover, an opening 190 having a width of W_a is formed along the contour of the concave portion 5.

In this case, as shown in FIG. 11B, the both faces of the silicon substrate 104 are etched by using, for example, a potassium-hydroxide aqueous solution. As described above, etching first progresses so that an opening becomes smaller as the etching becomes deeper because of the difference in etching rate between the (100) and (111) equivalent planes.

Then, as shown in FIG. 11C, in the case of the opening 190 having the width of W_a , all planes become the (111) equivalent plane before the etching reaches the center of the silicon substrate 104 and the etching stops. Therefore, the V-shaped concave portion 5 is formed. Moreover, in the case of the opening 191 having the width of W_a , etching processes

until it penetrates the substrate. As described above, because the (111) equivalent plane tilts from the (100) equivalent plane by an angle of 54.7° , the relation between the width w of the opening and the
5 depth of the V-shaped concave portion 5 is shown as $d = w/2\tan 54.7^\circ$. That is, relations of $W_a < t/\tan 54.7^\circ$, and W_b and $W_c > t/\tan 54.7^\circ$ are satisfied. In this case, t denotes the thickness of the silicon substrate 104.

10 Then, as shown in FIG. 11D, the etching from the lower face progresses until it penetrates the silicon substrate 104 and stops at the mask layer 101.

In the above anisotropic etching step, the sectional shape of the elastic support portion 3
15 taken along the line R-R in FIGS. 9A is formed into a V-shaped polygon enclosed by the (100) and (111) equivalent planes.

At the same time, the support substrate 2 and movable plate 6 are also formed into shapes enclosed
20 by the (100) and (111) planes shown in FIG. 8 in the etching step.

Finally, as shown in FIG. 11E, the mask layer 101 is removed and the support substrate 2, elastic support portion 3, movable plate 6 and concave
25 portion 5 are integrally formed.

(Third embodiment)

FIG. 12 is an illustration showing an

embodiment of an optical apparatus using the above micro optical deflector. In this case, an image display apparatus is shown as an optical apparatus. In FIG. 12, numeral 201 denotes a micro optical deflector group 21 in which two micro optical deflectors of the first embodiment are arranged so that their deflective directions are orthogonal to each other and which is used as an optical scanner system for raster-scanning incident light in horizontal and vertical directions in the case of this embodiment. Numeral 202 denotes a laser beam source. Numeral 203 denotes a lens or a lens group, 204 denotes a write lens or a write lens group and 205 denotes a projection plane. A laser beam incoming from the laser beam source 202 undergoes predetermined intensity modulation relating to light scanning timing and performs two-dimensional scanning by the micro optical deflector group 201. The laser beam used for the scanning forms an image on the projection plane 205 by the write lens 204. That is, the image display apparatus of this embodiment can be applied to a display.

(Fourth embodiment)

FIG. 13 is an illustration showing another embodiment of the optical apparatus using the above micro optical deflector. In this case, an electrophotographic image-forming apparatus is shown

as an optical apparatus. In FIG. 13, numeral 201 denotes the micro optical deflector of the first embodiment which is used as an optical scanner system for one-dimensionally scanning incident light in the case of the fourth embodiment. Numeral 202 denotes a laser beam source. Numeral 203 denotes a lens or a lens group, 204 denotes a write lens or a write lens group and 206 denotes a photosensitive member. A laser beam emitted from the laser beam source undergoes predetermined intensity modulation relating to light scanning timing and performs one-dimensional scanning by the micro optical deflector 201. The laser beam used for the scanning forms an image on the photosensitive member 206 by the write lens 204.

The photoconductor 206 is uniformly electrified by an electrification unit (not shown) and forms an electrostatic latent image on the surface of the photosensitive member 206 by scanning the surface with a beam. Then, a toner image is formed at the image portion of the electrostatic latent image by a development unit (not shown) and an image is formed on a sheet (not shown) by transferring and fixing the toner image to and on the sheet.

As described in accordance with the above embodiments, a microstructure of the present invention is capable of moderating stress concentration on the joint between an elastic support

portion, movable plate and support substrate at the time of torsion driving, preventing the elastic support portion from breaking and having a large displacement angle and a long service life by forming
5 a concave portion on the elastic support portion, constituting the elastic support portion so that a section in which the concave portion is not formed is formed at the both ends of a section in which the concave portion is formed and connecting the section
10 in which the concave portion is not formed with the movable plate and support substrate.

Moreover, by forming the concave portion, it is possible to realize a mode in which the elastic support portion is easily twisted but it is not
15 easily deflected in the direction for translating and vibrating the movable plate (direction vertical to torsion axis) and realize a microstructure to be driven in accordance with stable torsional vibration having less unnecessary vibration due to disturbance
20 or the like.

Therefore, it is possible to realize a microstructure having a small size, a long service life and less unnecessary vibration even for a large displacement angle.